

<b>Search Notes</b> 	<b>Application/Control No.</b> 09/845,923	<b>Applicant(s)/Patent under Reexamination</b> KENNEDY, PATRICK
<b>Examiner</b> Patricia Leith	<b>Art Unit</b> 1655	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
updated EAST:JPO,EPO,DERWENT,USPATF ULL,USPGPUBS,OCRBACKFILE	7/31/2006	PL
Updated EAST cont...	8/2/2006	PL
Updated Inventor name search PALM/EAST	8/2/2006	PL

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
424	94.65	8/2/2006	PL
424	94.1,94.2	8/2/2006	PL
424	94.21	8/2/2006	PL